

# Physics of Life

PHYS-468

## **OCT**

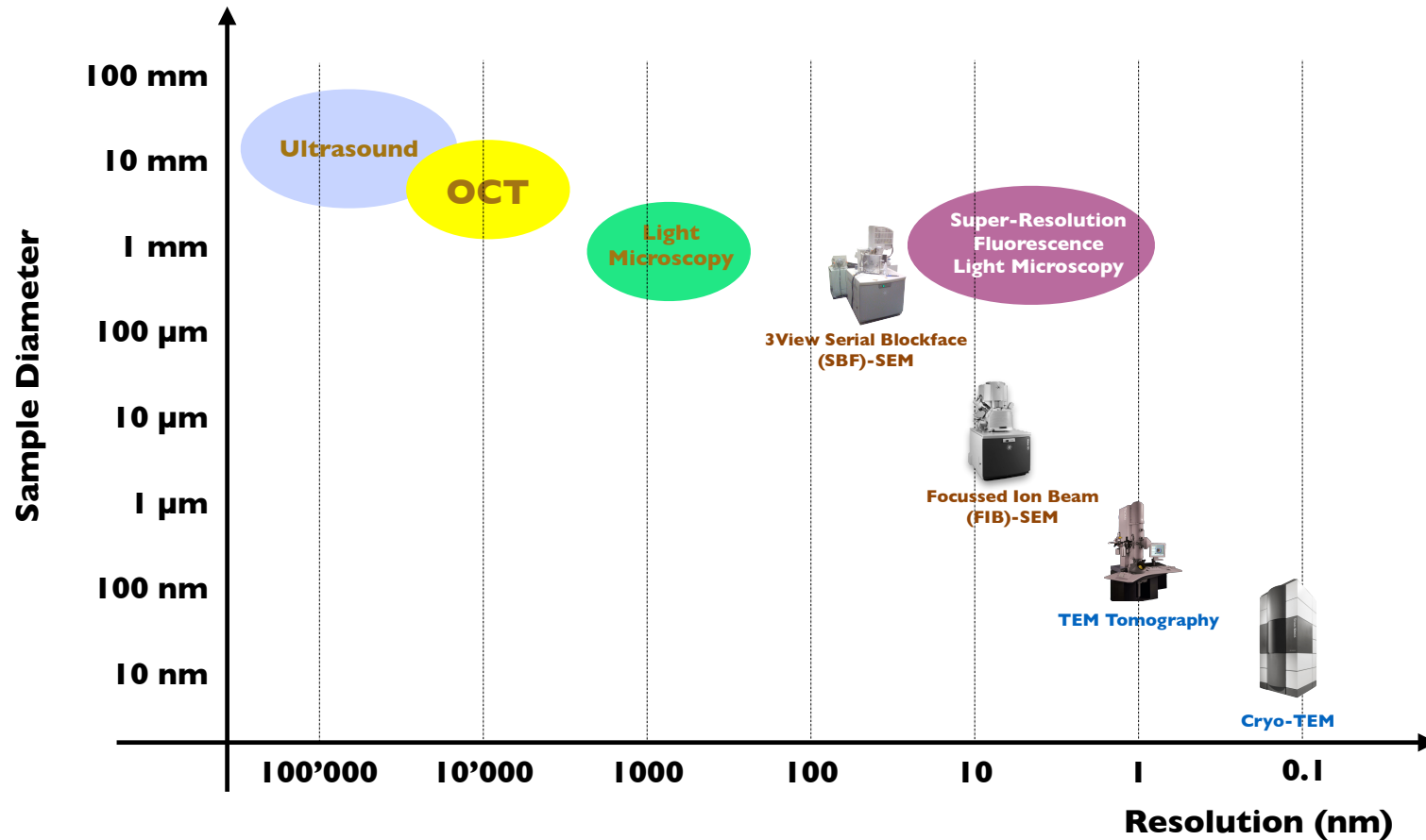
# **Optical Coherence Tomography**

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## Techniques to probe samples in 3D with beams:

Technique	Beam	Sample	Resolution
<b>SPECT (single photon emission)</b>	(gamma emission)	Human	2 mm
<b>PET (positron emission)</b>	(pair of gamma emission)	Human	1 mm
<b>CT</b>	X-ray	Human	0.5 mm
<b>Ultrasound</b>	sound	tissue	0.3 mm
<b>MRI</b>	(magnetic field)	Human	0.1 mm
<b>OCT</b>	IR light	2 mm	10 $\mu$ m
<b>Synchrotron X-ray tomography</b>	X-ray	2 mm	100 nm
<b>Synchrotron X-ray ptychography</b>	X-ray	2 mm	30 nm
<b>Helium microscopy</b>	He <sup>2+</sup>	100 nm	1 nm
<b>Electron microscopy: SBF-SEM</b>	electron (3kV)	1 mm	3 nm
<b>Electron microscopy: FIB-SEM</b>	electron (3kV)	30 $\mu$ m	2 nm
<b>Electron microscopy: TEM</b>	electron (300kV)	500 nm	0.1 nm

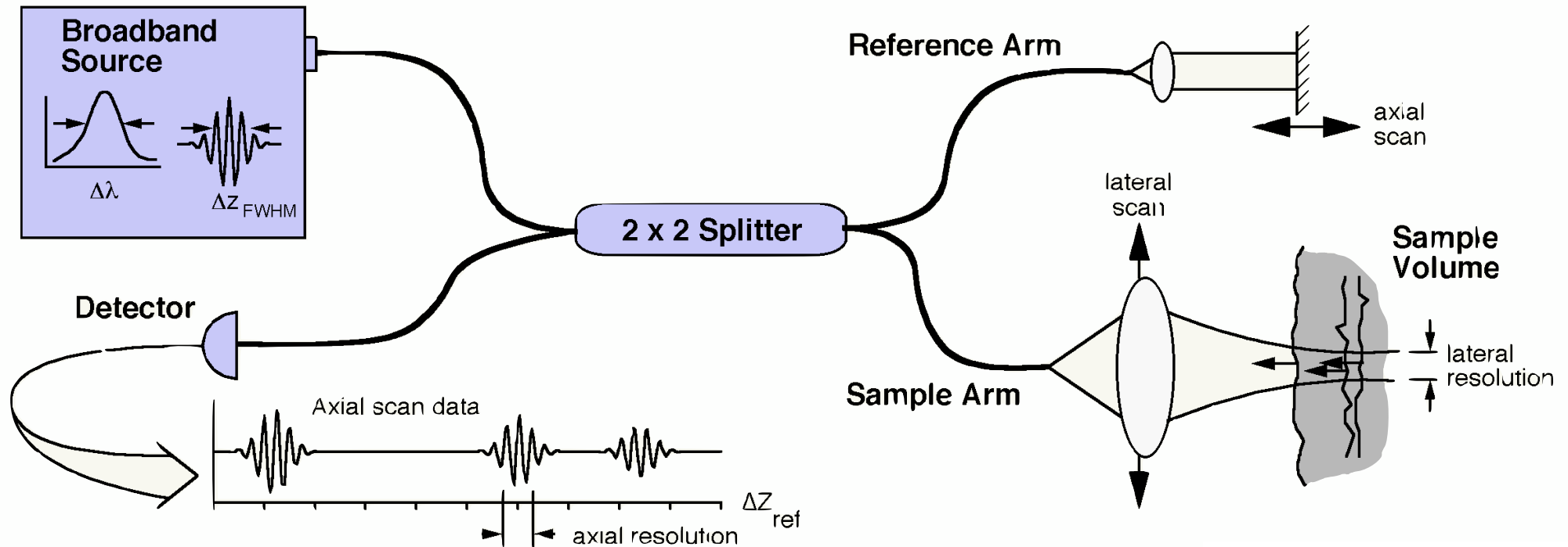
# Multi-Resolution 3D Microscopy



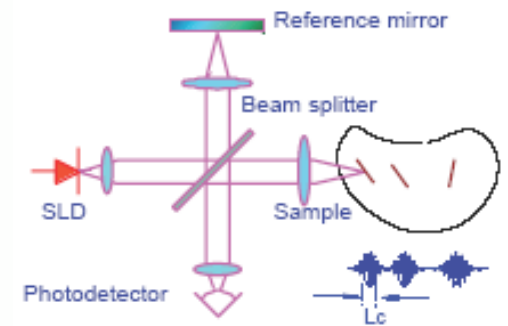
No single instrument can cover all scales.

# Optical Coherence Tomography (OCT)

Michelson Interferometer with a broad-band partially coherent light source



Interferometry is used to measure small time delays of scattered photons



# Optical Coherence Tomography (OCT)

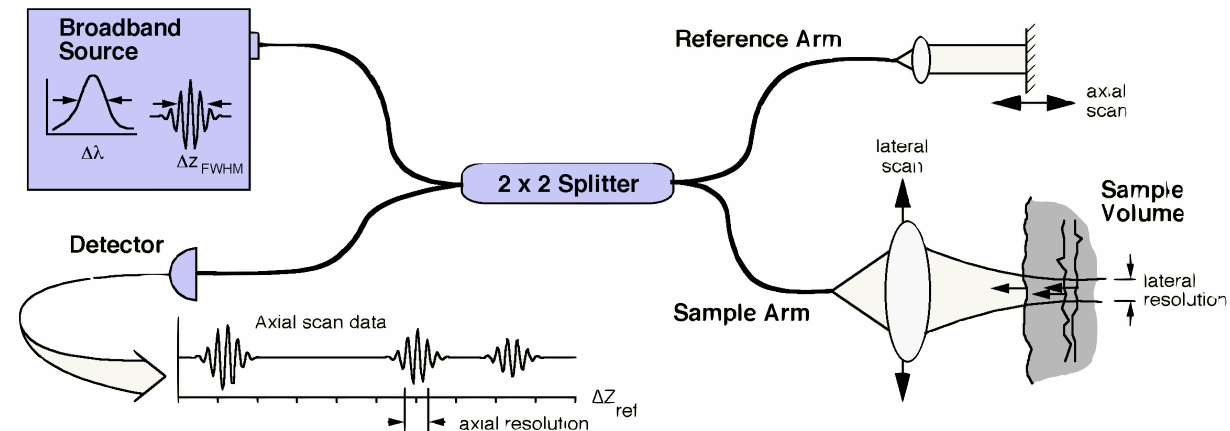
OCT is analogous to ultrasound imaging  
Uses infrared light instead of sound



Speed of sound  $\sim 1480$  m/sec (in water)  
Speed of light  $- 3 \times 10^8$  m/sec

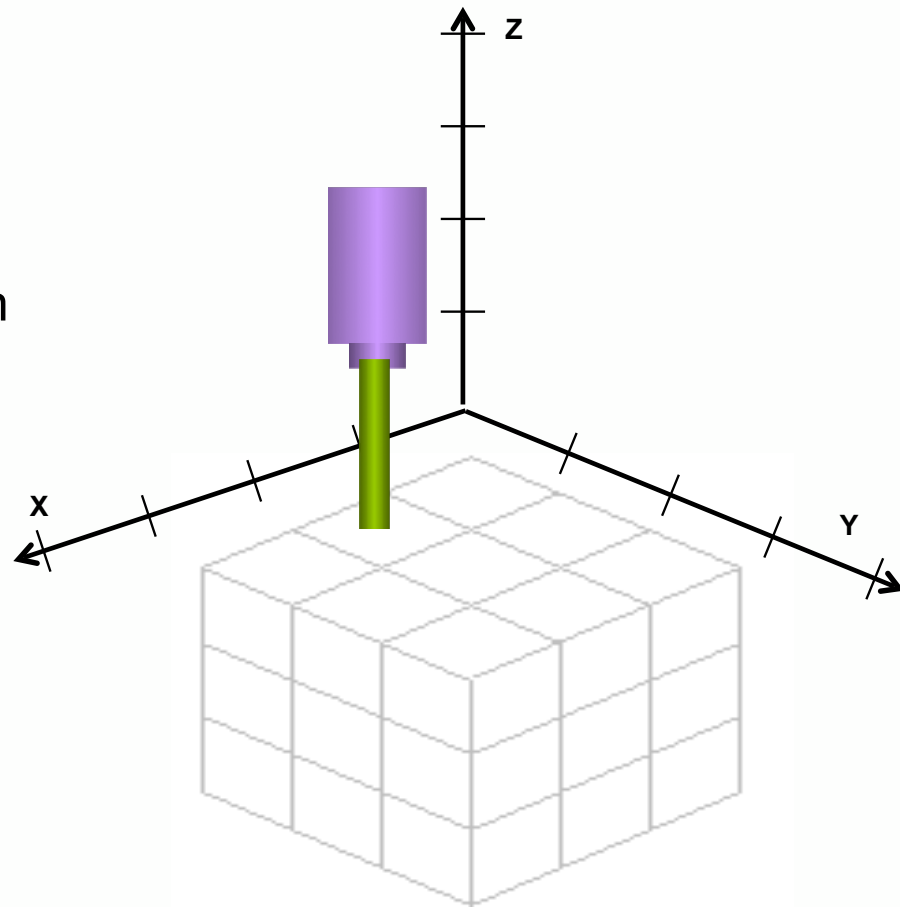
Human skin  
*5 mm wide x 1.6 mm deep*  
Spatial Resolution:  $10\text{-}30 \mu\text{m}$

Interferometry  
is used to measure  
small time delays  
of scattered photons



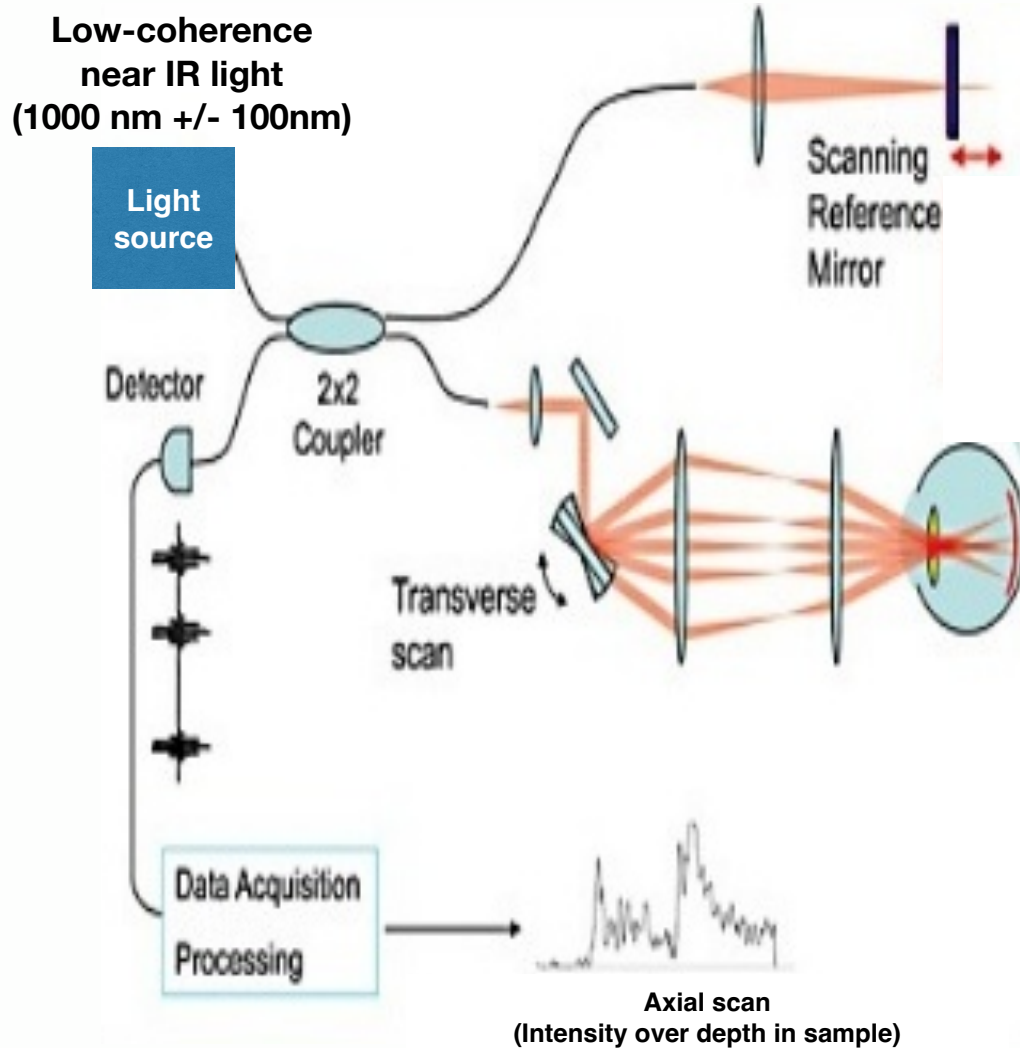
# Optical Coherence Tomography (OCT)

- Surface of sample is divided into imaginary grid of  $10\mu\text{m}$  pixels
- The Z-profile is recorded at each pixel
- Scanning in X and Y direction gives the 3D volume



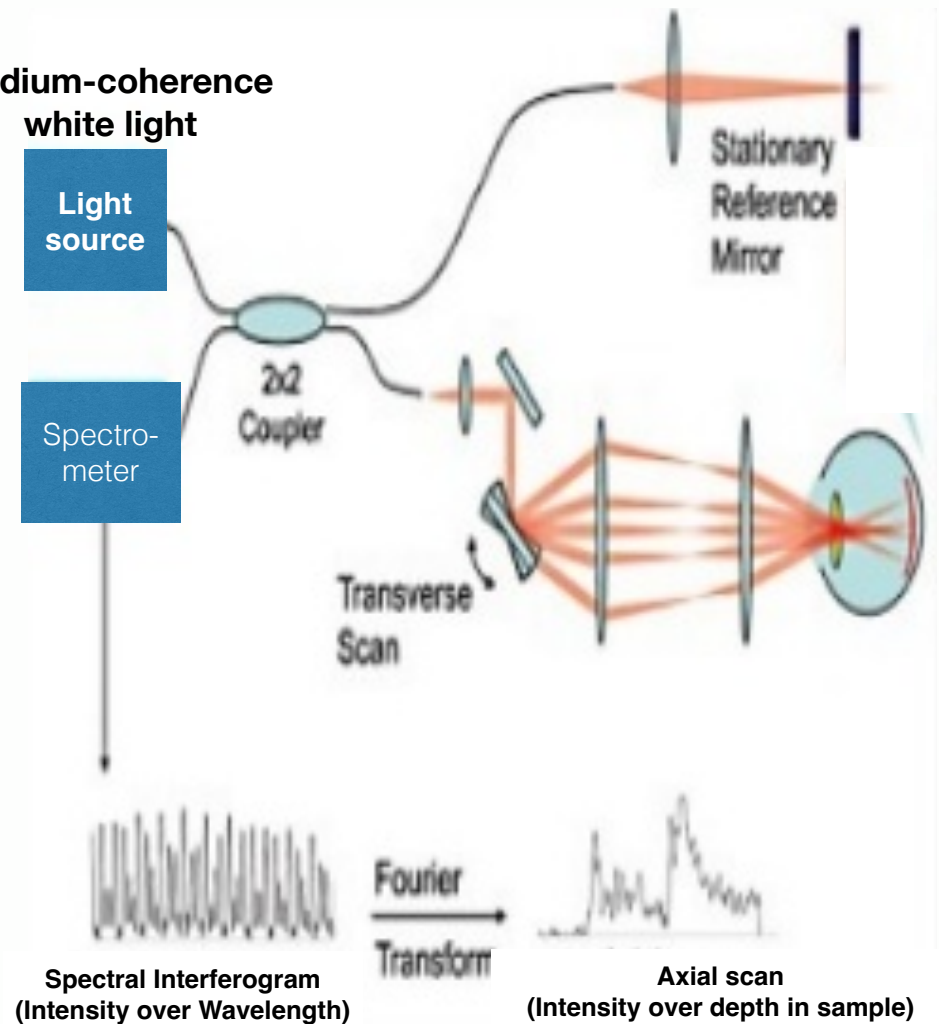
# Optical Coherence Tomography (OCT)

## Time Domain OCT



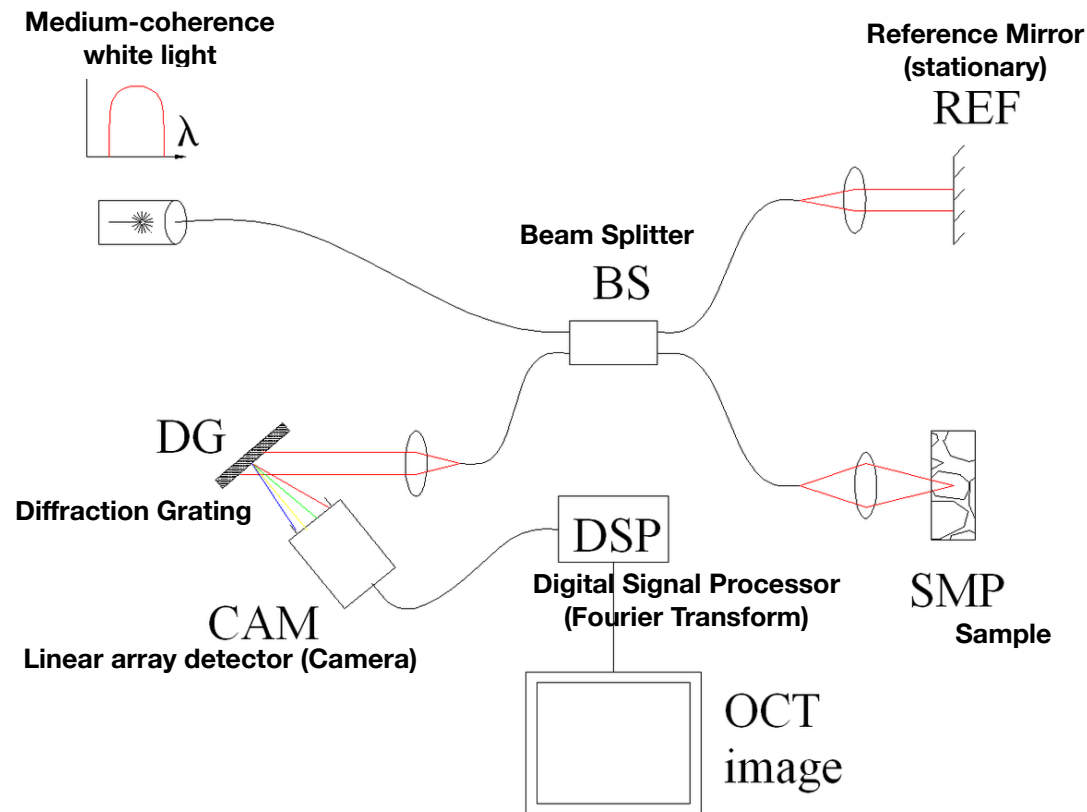
## Fourier Domain OCT

Medium-coherence  
white light

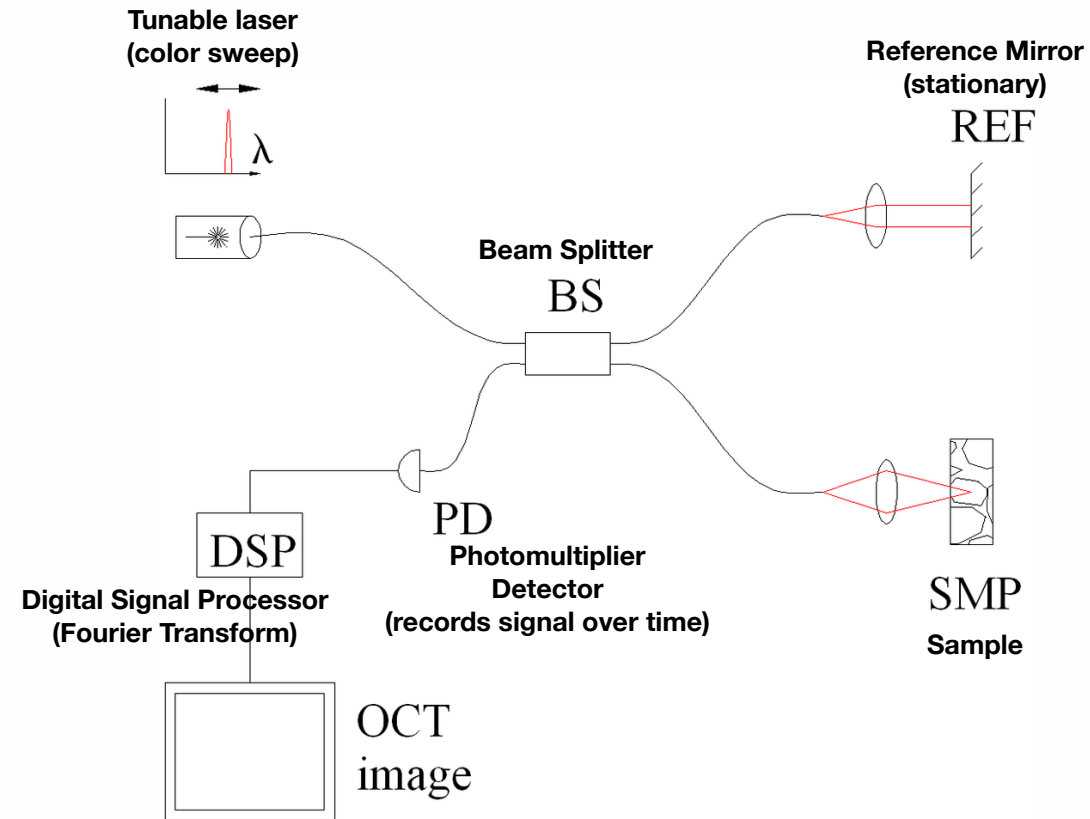


# Fourier-Domain Optical Coherence Tomography (OCT)

All colors on the same time => Faster, but lower resolution



One color at a time => Better resolution but slower





# Optical Coherence Tomography (OCT)

## TD – OCT (Time domain)

- Reference mirror moves
- 1 pixel of depth scan at a time
- Slow
- Motion artefacts present
- Less sharp images

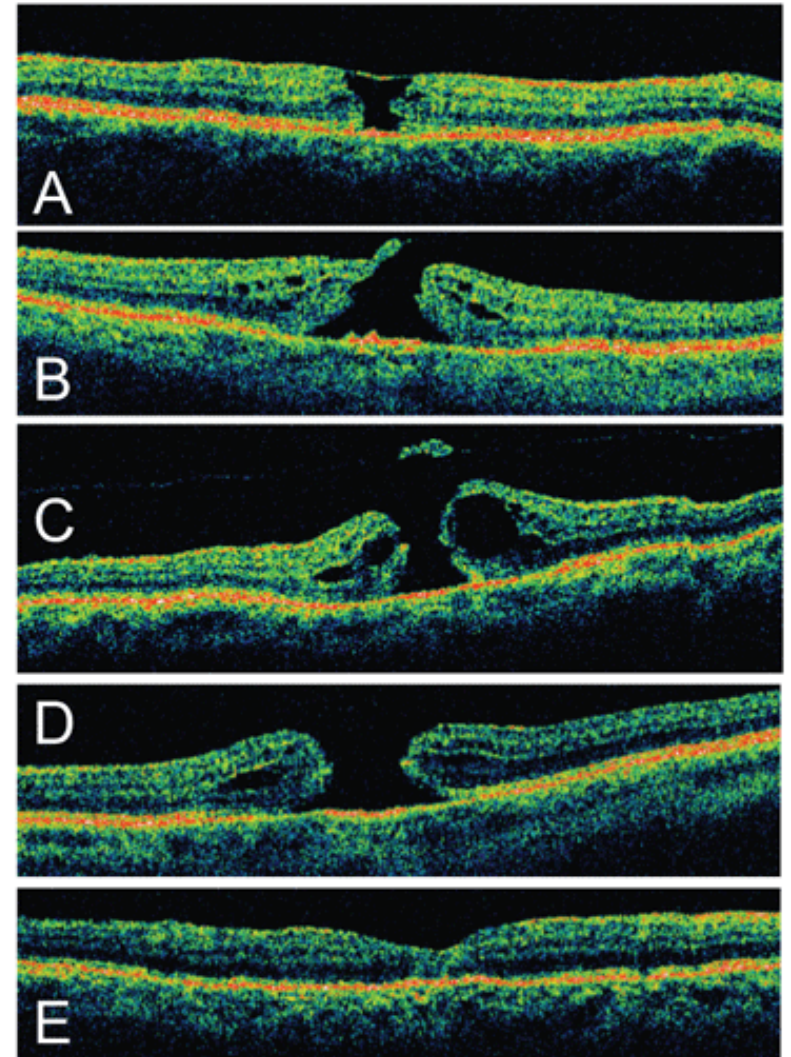
## FD – OCT (Fourier domain)

- Reference mirror stationary
- Use white light and record entire spectrum at once
- Interference detected by spatial interferogram
- Interference pattern Fourier transformed
- 2048 pixels (full depth profile) at a time
- Rapid
- No motion artefacts
- Sharper and clear images

# Optical Coherence Tomography (OCT)



## 1. Macular Hole



- 3D analysis of retina. This patient had a hole in the retina.
- OCT can be used to monitor the course of the disease and the response to surgical intervention.

# Optical Coherence Tomography (OCT)

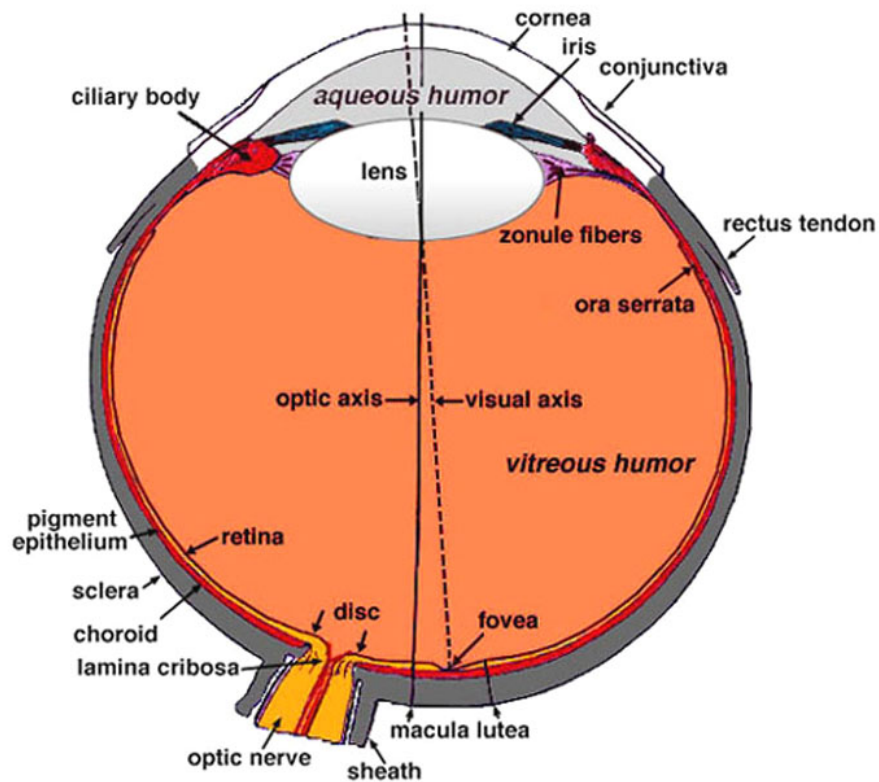
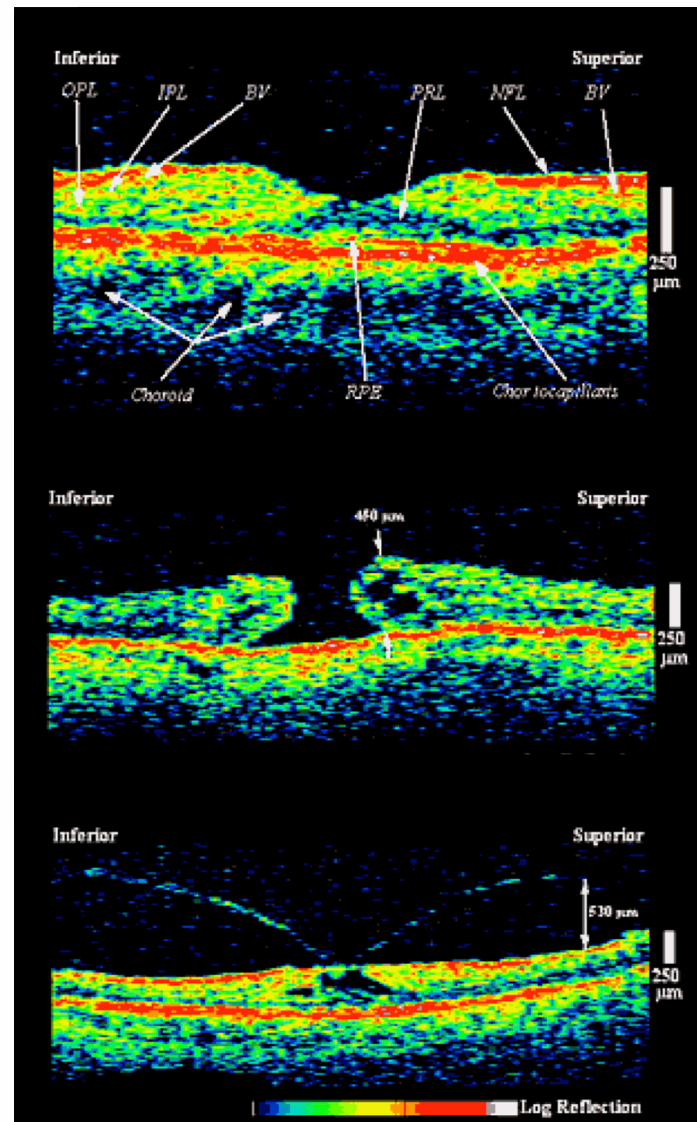


Fig. 2. Sagittal horizontal section of the adult human eye.



Normal patient

Patient with impaired vision (20/80):  
The cause is a macular hole

Patient's other eye (vision 20/25):  
Impending macular hole, which can  
be treated



# Optical Coherence Tomography (OCT)

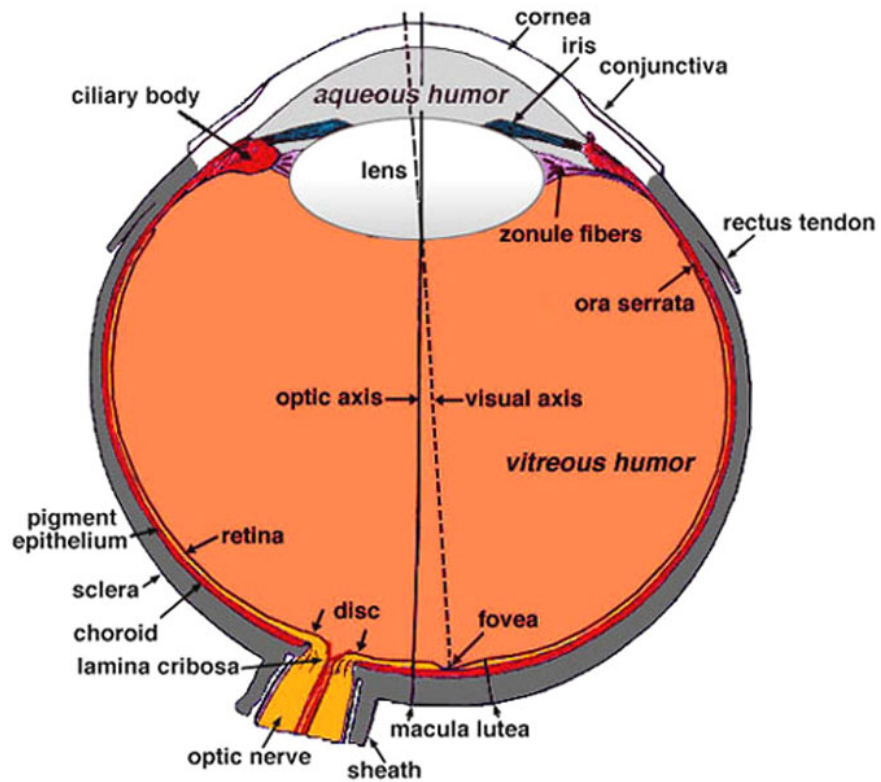
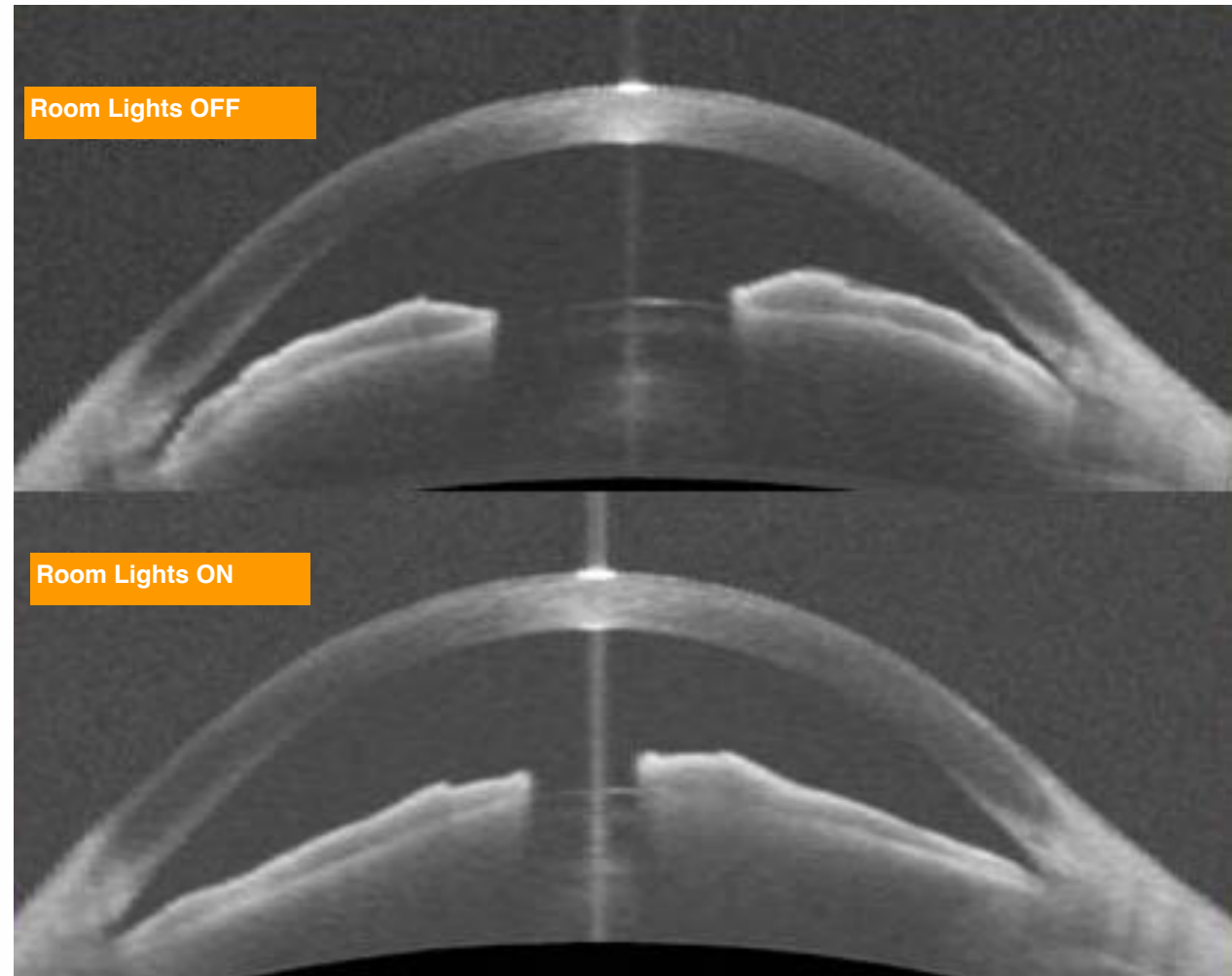


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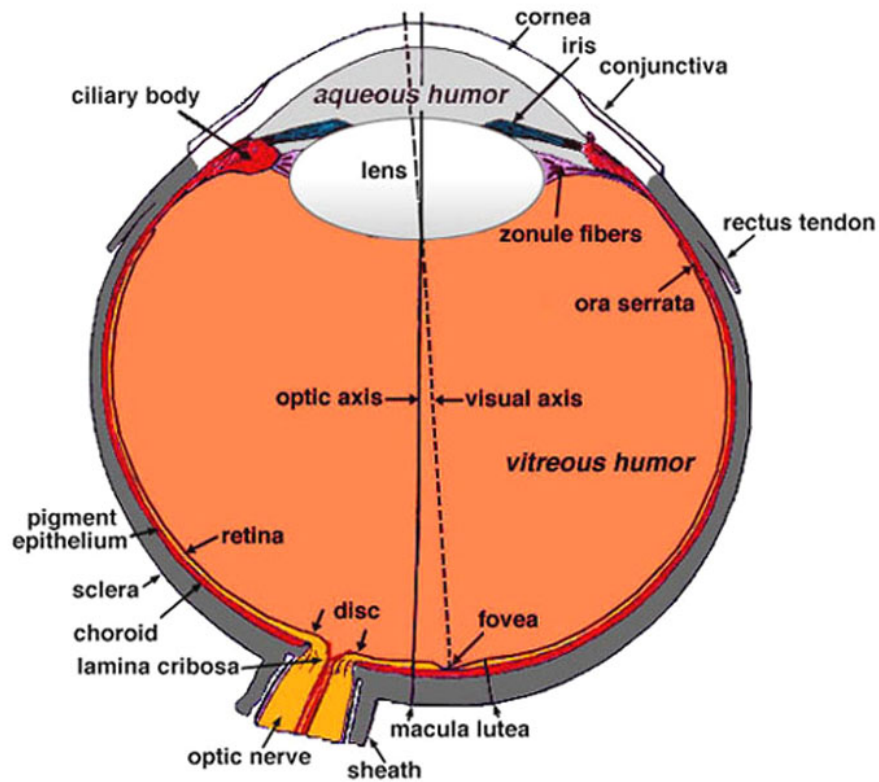
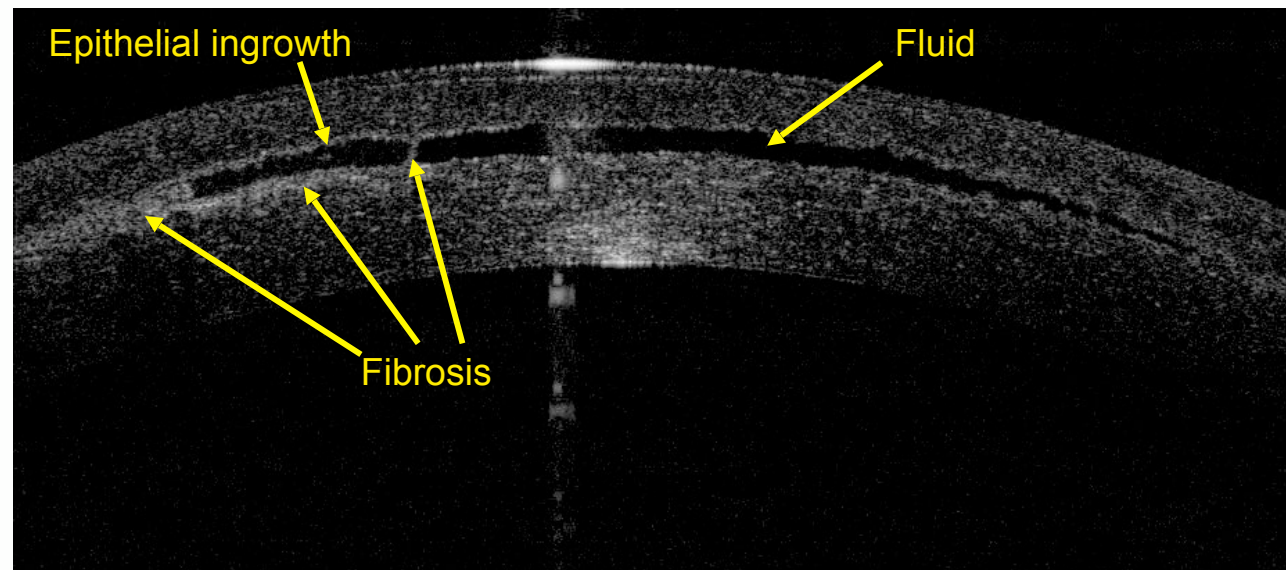


Fig. 2. Sagittal horizontal section of the adult human eye.

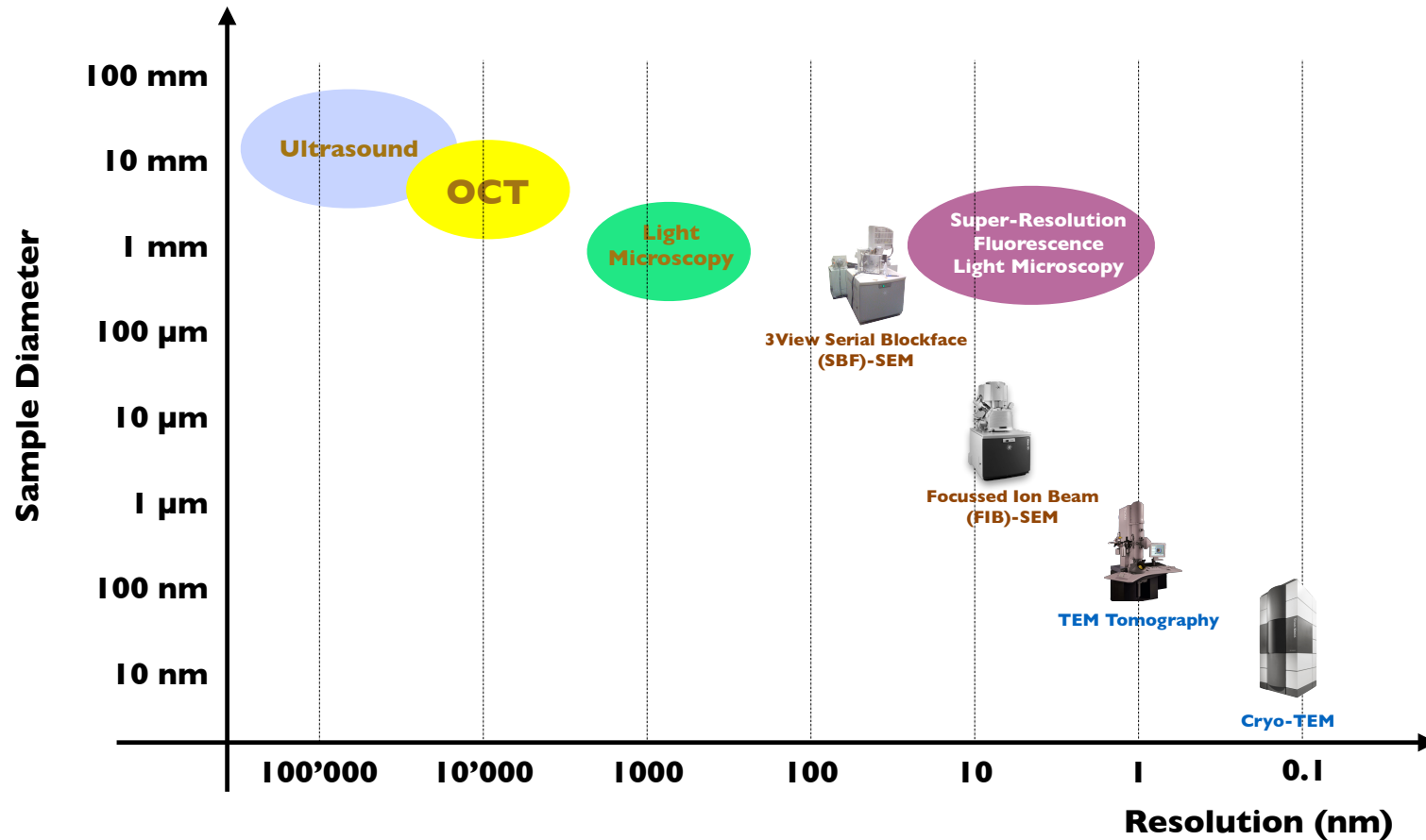
Post-LASIK interface fluid & epithelial ingrowth



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